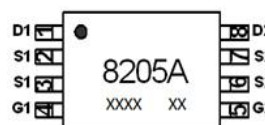
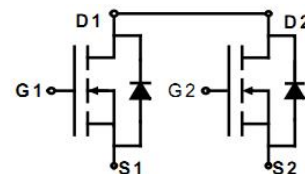


**Main Product Characteristics:**

$V_{DSS}$	20V
$R_{DS(on)}$	19.6m $\Omega$ (typ.)
$I_D$	6A


**TSSOP-8**

**Marking and Pin Assignments**

**Schematic Diagram**
**Features and Benefits:**

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature


**Description:**

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

**Absolute max Rating:**

Symbol	Parameter	Max.	Units
$I_D @ TC = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ ①	6	A
$I_{DM}$	Pulsed Drain Current ②	25	
$P_D @ TC = 25^\circ C$	Power Dissipation ③	1.5	W
$V_{DS}$	Drain-Source Voltage	20	V
$V_{GS}$	Gate-to-Source Voltage	$\pm 10$	V
$E_{AS}$	Single Pulse Avalanche Energy @ $L=0.5mH$	12	mJ
$T_J \quad T_{STG}$	Operating Junction and Storage Temperature Range	-55 to +150	$^\circ C$

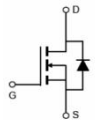
## Thermal Resistance

Symbol	Characterizes	Typ.	Max.	Units
R <sub>θJA</sub>	Junction-to-ambient (t ≤ 10s) ④	—	83	°C/W

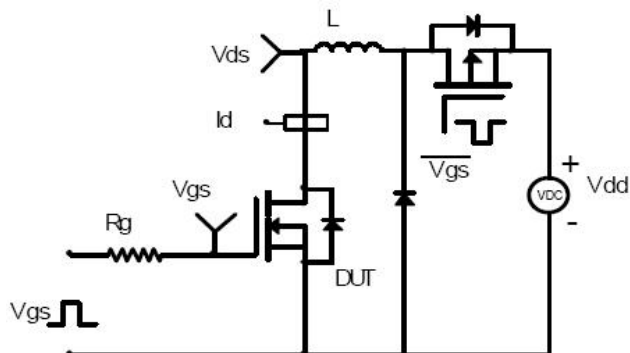
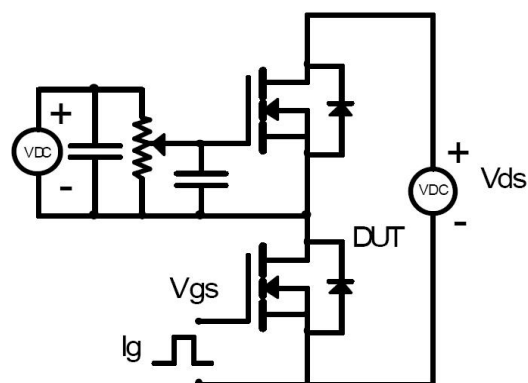
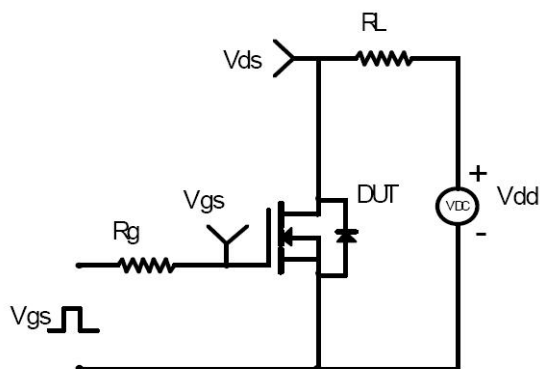
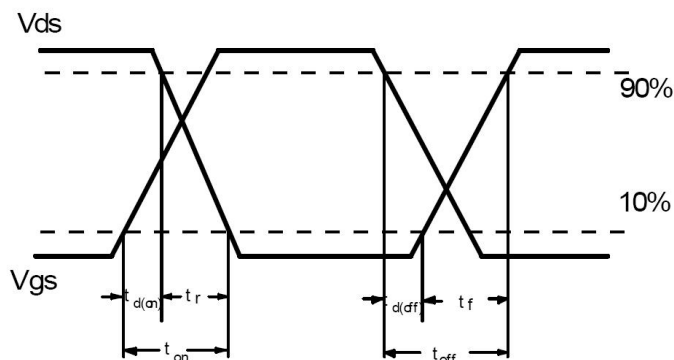
## Electrical Characterizes @T<sub>A</sub>=25°C unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source breakdown voltage	20	—	—	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA
R <sub>DS(on)</sub>	Static Drain-to-Source on-resistance	—	19.6	27.5	mΩ	V <sub>GS</sub> =4.5V, I <sub>D</sub> =4.5A
		—	24.3	37.5		V <sub>GS</sub> =2.5V, I <sub>D</sub> =3.5A
V <sub>GS(th)</sub>	Gate threshold voltage	0.5	—	1.2	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250μA
I <sub>DSS</sub>	Drain-to-Source leakage current	—	—	1	μA	V <sub>DS</sub> = 18V, V <sub>GS</sub> = 0V
I <sub>GSS</sub>	Gate-to-Source forward leakage	—	—	100	nA	V <sub>GS</sub> = 10V
		—	—	-100		V <sub>GS</sub> = -10V
Q <sub>g</sub>	Total gate charge	—	10	—	nC	I <sub>D</sub> = 6A, V <sub>DS</sub> =10V, V <sub>GS</sub> = 4.5V
Q <sub>gs</sub>	Gate-to-Source charge	—	2.3	—		
Q <sub>gd</sub>	Gate-to-Drain("Miller") charge	—	3	—		
t <sub>d(on)</sub>	Turn-on delay time	—	10	—	ns	V <sub>GS</sub> =4.5V, V <sub>DS</sub> =10V, R <sub>GEN</sub> =6Ω I <sub>D</sub> = 1A
t <sub>r</sub>	Rise time	—	11	—		
t <sub>d(off)</sub>	Turn-Off delay time	—	35	—		
t <sub>f</sub>	Fall time	—	30	—		
C <sub>iss</sub>	Input capacitance	—	409	—	pF	V <sub>GS</sub> = 0V V <sub>DS</sub> = 8V f = 1MHz
C <sub>oss</sub>	Output capacitance	—	95	—		
C <sub>riss</sub>	Reverse transfer capacitance	—	69	—		

## Source-Drain Ratings and Characteristics

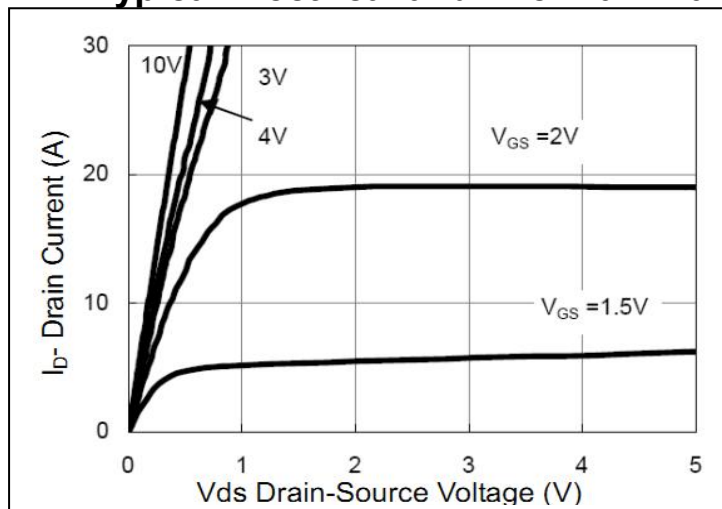
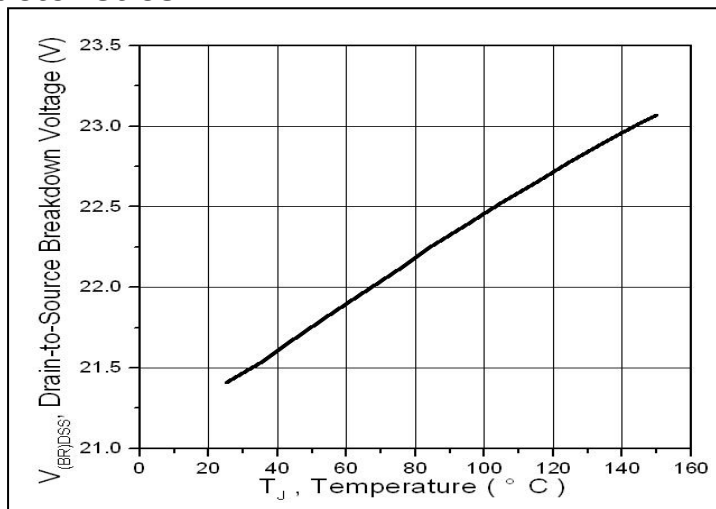
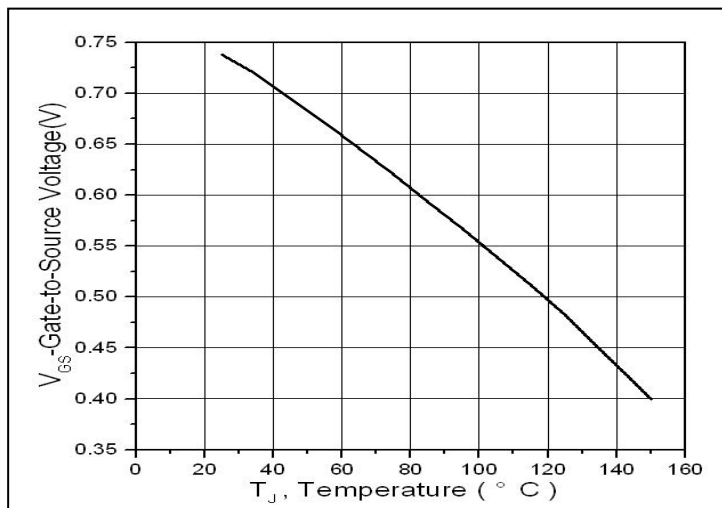
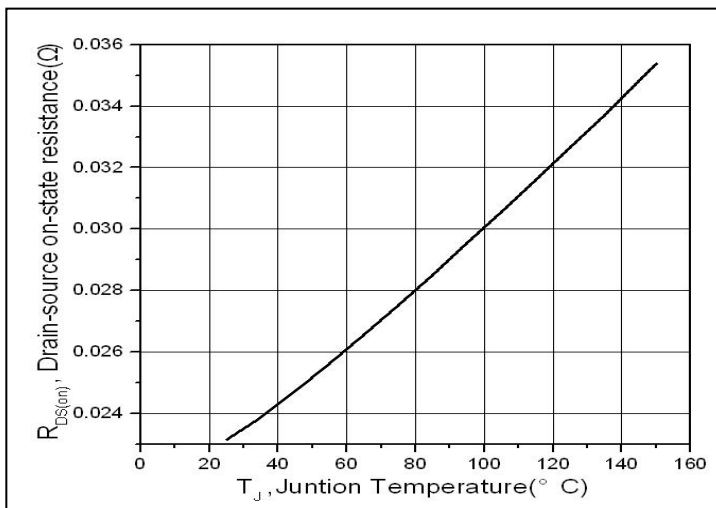
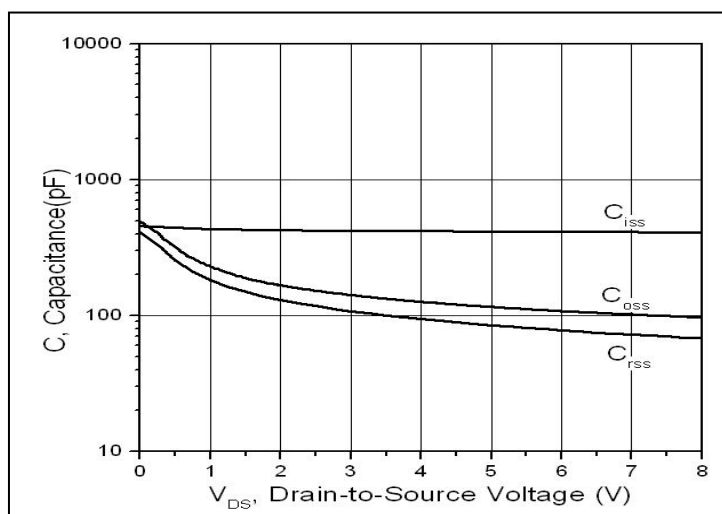
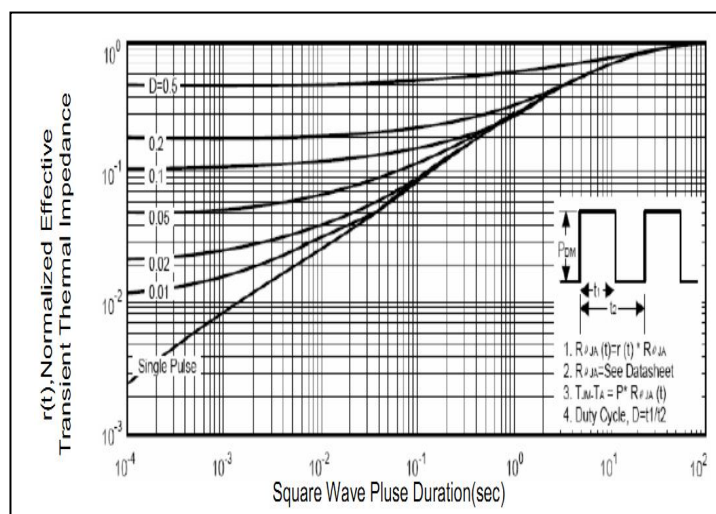
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)	—	—	1.7	A	MOSFET symbol showing the integral reverse p-n junction diode. 
V <sub>SD</sub>	Diode Forward Voltage	—	0.8	1.2	V	I <sub>S</sub> =1.7A, V <sub>GS</sub> =0V

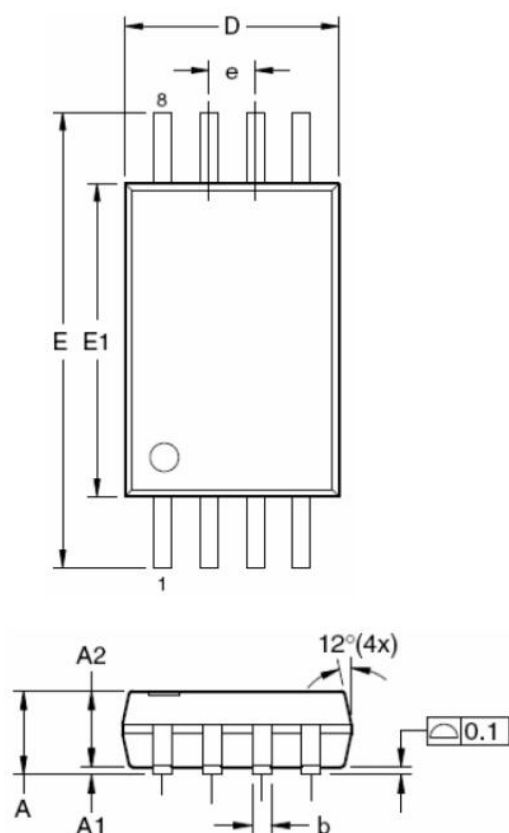
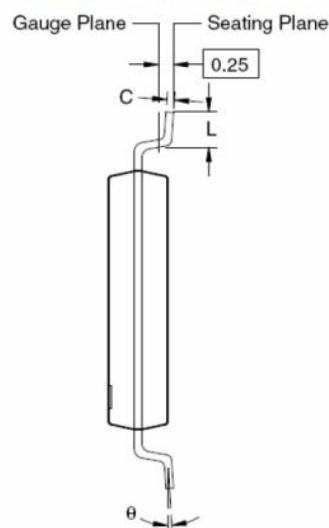
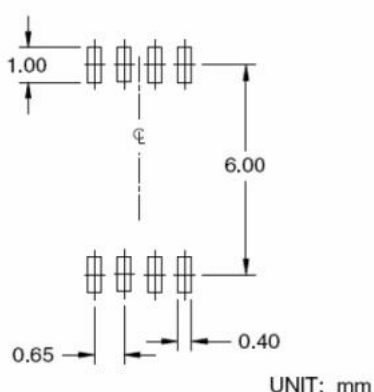
## Test circuits and Waveforms

**EAS Test Circuit:**

**Gate charge test circuit:**

**Switching Time Test Circuit:**

**Switching Waveforms:**


### Notes:

- ① Calculated continuous current based on maximum allowable junction temperature.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- ④ The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^\circ\text{C}$

**Typical Electrical and Thermal Characteristics**

**Figure 1. Typical Output Characteristics**

**Figure 2. Drain-to-Source Breakdown Voltage vs. Temperature**

**Figure 3. Gate to source cut-off voltage**

**Figure 4. Normalized On-Resistance vs. Case Temperature**

**Figure 5. Capacitance**

**Figure 6. Maximum Effective Transient Thermal Impedance, Junction-to-Case**

**Mechanical Data:**

**Dimensions in Millimeters (UNIT:mm)**

**RECOMMENDED LAND PATTERN**

**Dimensions in millimeters**

Symbols	Min.	Nom.	Max.
A	—	—	1.20
A1	0.05	—	0.15
A2	0.80	1.00	1.05
b	0.19	—	0.30
C	0.09	—	0.20
D	2.90	3.00	3.10
E	6.40 BSC		
E1	4.30	4.40	4.50
e	0.65 BSC		
L	0.45	0.60	0.75
θ	0°	—	8°

**Dimensions in inches**

Symbols	Min.	Nom.	Max.
A	—	—	0.047
A1	0.002	—	0.006
A2	0.031	0.039	0.041
b	0.007	—	0.012
C	0.004	—	0.008
D	0.114	0.118	0.122
E	0.252 BSC		
E1	0.169	0.173	0.177
e	0.026 BSC		
L	0.018	0.024	0.030
θ	0°	—	8°

**NOTES:**

1. All dimensions are in millimeters.
2. Dimensions are inclusive of plating
3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 6 mils.
4. Dimension L is measured in gauge plane.
5. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.

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